Detector B07-W0276

1 Detector Details and Basic Parameters

Readout: MiniPIX (sn: 108) **Full Name:** MiniPIX B07-W0276

Chip: Timepix **Sensor:** Si $(300 \ \mu m)$

 Temperature:
 22.0

 Pixet Version:
 1.4.10.706

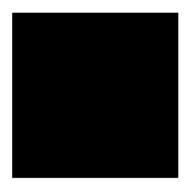
 TpxSetup Version:
 1.9 (31.7.2018)

 Date:
 04.10.2018 12:26:11

Responsible: Matous

Parameter	Value	Reason	
Timepix Clock	10.0	Noise reduction	
Ikrum	1	Better energy resolution	
FBK	159	Wider energy range in ToT mode	
THL Coarse	8	Wider energy range of threshold	
Preamp	225	Lower power consumption and heat	

2 Digital Test and Bias Test

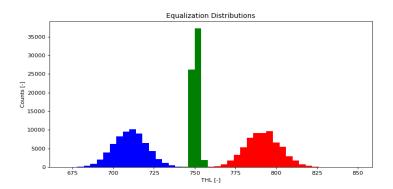


Bad Pixels: 0

3 Bias Leakage Test

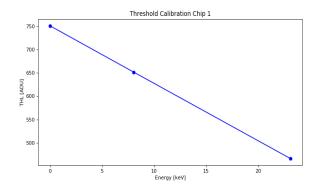
Bias [V]	Leaking Pixels [cnt]	Leaking Current [µA]	Voltage Sense [V]
0	0.0000	0.0000	0.0000
20	0.0000	0.0000	0.0000
40	0.0000	0.0000	0.0000
60	0.0000	0.0000	0.0000
80	0.0000	0.0000	0.0000
100	0.0000	0.0000	0.0000
120	0.0000	0.0000	0.0000
140	0.0000	0.0000	0.0000
160	0.0000	0.0000	0.0000
180	1.0000	0.0000	0.0000
200	2.0000	0.0000	0.0000

4 Threshold Equalization



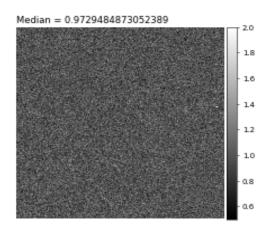
Parameter	Value		
Mean THL	750.514		
Std. Dev	2.265		
Masked Pixels	2		
Final THL	715		

5 Threshold Energy Calibration

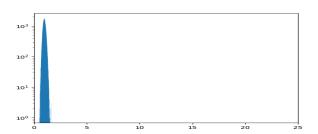


Parameter	Value
A	12.282
В	49.819
\mathbf{W}	0.208
T	8.249
K	1.000
Min. Threshold	2.864 keV
THL 5 keV	688.771

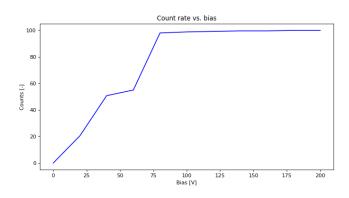
6 Stability Test with Cd XRF 23.106 keV, duration: 10.0 min



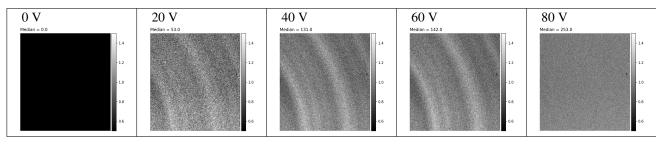
Median:0.973Pixel Median Range:0.5-2.0Deviating Pixels 2 σ :0.008%Deviating Pixels 5 σ :0.003%Global Stability:0.147%

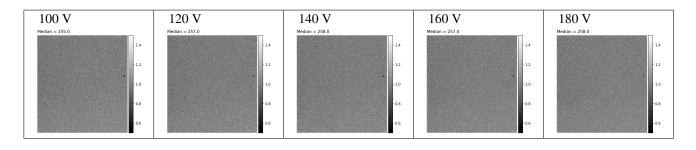


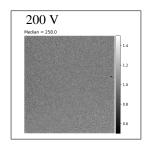
7 Bias Test with Fe XRF (6.4keV)



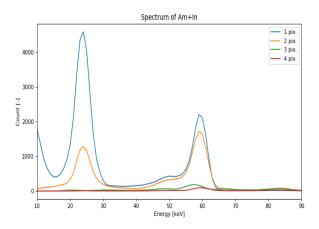
Parameter	Value	
Bias From	160	
Bias To	200	
Bias Step	20	







8 Energy Calibration in ToT Mode

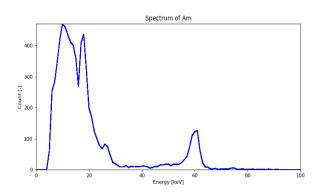


Source	Energy	1	2	3	4
Fe	6.229	5.647	10.858	3.000	3.000
In	24.219	23.817	23.919	19.634	24.413
Am	59.561	59.465	59.337	57.608	59.561

Coefficient	Mean value
A	1.000
В	25.000
C	38.000
T	3.000

9 Calibration Verification

Verification from the front side of the detector



Source	Energy	Sigma
Am	59.504	2.628

10 Summary and Classification

Calibrated for threshold of 5 keV (THL=688)

Criterion	Value	Unit	Class
ROC (Wafer probing result)	-	-	A
Masked pixels	9	cnt	A
Bad pixels after test with sources	0	cnt	AA
Largest bad cluster pixel count	0	cnt	AA
Min. threshold Medipix mode	2.864	keV	AA
Energy resolution ToT at 60 keV	1.977	keV	AA

Final Statement	Class	Verbal
Imaging applications (Counting mode)	A	Very good
Tracking applications (Energy mode)	A	Very good